Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/807,357	HAMADA ET AL.
Examiner	Art Unit
Thinh T. Nguyen	2818

SEARCHED				
Class	Subclass	Date	Examiner	
257	295	6/22/2006	TTN	
257	296	6/22/2006	TTN	
257	E21.664	6/22/2006	TTN	
257	E21.663	6/22/2006	TTN	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
EAST	PUB	11/15/06	MIT	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	6/22/2006	TTN
EAST	11/15/0.6	TTA
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